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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/751,939	01/02/2001	Jae Goan Jeong	P 275428 2000-OPH-2055	8888
909	7590 12/04/2002			
PILLSBURY WINTHROP, LLP		EXAMINER		
P.O. BOX 10500 MCLEAN, VA 22102			VU, DAVID	
,			ART UNIT	PAPER NUMBER
			2818	
		DATE MAILED: 12/04/2002		

Please find below and/or attached an Office communication concerning this application or proceeding.

#### Application No. Applicant(s) 09/751,939 JEONG, JAE GOAN "Office Action Summary Examiner **Art Unit** DAVID VU 2818 -- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --**Period for Reply** A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION. Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication. If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely. If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication. Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b). Status 1) 🖂 Responsive to communication(s) filed on <u>08 November 2002</u>. 2a) □ This action is FINAL. 2b) This action is non-final. Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213. **Disposition of Claims** 4) Claim(s) 1-3 is/are pending in the application. 4a) Of the above claim(s) 4-6 is/are withdrawn from consideration. 5) Claim(s) \_\_\_\_\_ is/are allowed. 6) ☐ Claim(s) <u>1-3</u> is/are rejected. 7) Claim(s) \_\_\_\_ is/are objected to. 8) Claim(s) \_\_\_\_\_ are subject to restriction and/or election requirement. **Application Papers** 9) The specification is objected to by the Examiner. 10) The drawing(s) filed on <u>02 January 2001</u> is/are: a) accepted or b) objected to by the Examiner. Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a). 11) The proposed drawing correction filed on \_\_\_\_\_ is: a) approved b) disapproved by the Examiner. If approved, corrected drawings are required in reply to this Office action. 12) The oath or declaration is objected to by the Examiner. Priority under 35 U.S.C. §§ 119 and 120 13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) ☑ All b) ☐ Some \* c) ☐ None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No. \_\_\_\_ 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). \* See the attached detailed Office action for a list of the certified copies not received. 14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application). a) The translation of the foreign language provisional application has been received. 15) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121. Attachment(s) 1) Notice of References Cited (PTO-892) 4) Interview Summary (PTO-413) Paper No(s). 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) Notice of Informal Patent Application (PTO-152) 3) Information Disclosure Statement(s) (PTO-1449) Paper No(s) U.S. Patent and Trademark Office

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#### **DETAILED ACTION**

## Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(e) the invention was described in-

(1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effect under this subsection of a national application published under section 122(b) only if the international application designating the United States was published under Article 21(2)(a) of such treaty in the English language; or

(2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that a patent shall not be deemed filed in the United States for the purposes of this subsection based on the filing of an international application filed under the treaty defined in section 351(a).

1. Claims 1-3 are rejected under 35 U.S.C. 102(e) as being anticipated by Lin (US 6,074,921).

Lin, in related text (Col. 10, Line. 63-Col. 13, Line. 18) and figures (Fig. 5a-5f) discloses a transistor comprising: a device isolation film 424 formed on a semiconductor substrate 422, the device isolation film 424 having a groove that exposes a portion of the semiconductor substrate 422 defining an active region and having a substantially vertical profile with respect to the exposed portion of the semiconductor substrate 422; a gate electrode structure formed in a central portion of the active region of the semiconductor substrate 422 and separated from the device isolation film 424, wherein the gate electrode structure further comprises: a stacked structure of a gate oxide film 444, a first gate electrode 447 and a second electrode 443, an oxide layer 437 formed on a side wall of the first gate electrode 447, and nitride spacers 468 formed on the oxide layer 437 on the sidewall of the first gate electrode 447 and on a side wall of the device

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isolation film 424; lightly doped drain (LDD) regions formed in the active region of the semiconductor substrate on both sides of the gate electrode structure; source/drain regions 432/434 formed in the active region of the semiconductor substrate 422 on both sides of the gate electrode structure; and second and third insulating films 470/488 filling and plananizing the space above the active region and between the gate electrode structure and the device isolation film (Col. 12, Lines. 55-63).

In re claim 2, wherein, the vertical profile of the device isolation film is modified near the junction of the device isolation film and the semiconductor substrate such that the device isolation film has a substantially rounded profile (Fig. 5a)

In re claim 3, wherein a hard mask layer 490 is formed on the gate electrode (Fig. 5d-5e).

### Conclusion

2. Any inquiry concerning this communication or earlier communications from the examiner should be directed to David Vu whose telephone number is (703) 305-0391. The examiner can normally be reached on Monday-Friday from 8:00am to 5:00pm.

If attempt to reach the examiner by telephone are unsuccessful, the examiner's supervisor, David Nelms., can be reached on (703) 308-4910.

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David Vu

HOAIHO PRIMARY EXAMINER